

N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^{a, g}	Q _g (Typ.)		
30	0.0058 at V _{GS} = 10 V	60 ^g	30 nC		
	0.0097 at $V_{GS} = 4.5 \text{ V}$	60 ^g	30 110		

Top View

TO-251 N-Channel MOSFET

FEATURES

- DT-Trench Power MOSFET
- 100 % R_g Tested
- 100 % Avalanche Tested



APPLICATIONS

- Low-Side Switch for DC/DC Converters
 - Servers
 - POL
 - VRM
- OR-ing

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20		
Continuous Drain Current (T _J = 150 °C)	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	I _D	60 ^g 60 ^g 33 ^{b, c} 26 ^{b, c}		
Pulsed Drain Current		I _{DM}	180	_ A	
Continuous Source-Drain Diode Current	$T_C = 25 ^{\circ}C$ $T_A = 25 ^{\circ}C$	I _S	60 ^g 4.7 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	47		
Single Pulse Avalanche Energy		E _{AS}	121	mJ	
$ \begin{array}{c} T_{C}=2 \\ \hline T_{C}=7 \\ \hline T_{A}=2 \\ \hline T_{A}=7 \end{array} $		P _D	82 51 5.2 ^{b, c} 3.3 ^{b, c}	w	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		
Soldering Recommendations (Peak Temperature)		Ü	260	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient	t ≤ 10 s	R_{thJA}	18	23	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.0	1.5	C/VV	

- a. Based on T_C = 25 °C.
 b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.



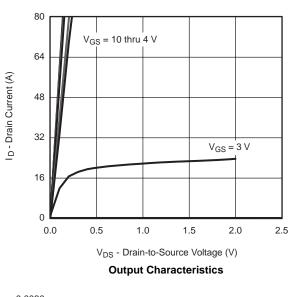
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	*						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		26		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_{D} = 250 \mu\text{A}$		- 6.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.7	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ	
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 20 A		0.0031	0.0058		
		$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0073	0.0097	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 20 A		100		S	
Dynamic ^b	•						
Input Capacitance	C _{iss}			4190		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		800			
Reverse Transfer Capacitance	C _{rss}			310			
Total Gate Charge	Q _g	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 20 A		71	100	nC	
				32	50		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		11			
Gate-Drain Charge	Q_{gd}			10			
Gate Resistance	R_g	f = 1 MHz	0.2	0.8	1.5	Ω	
Turn-On Delay Time	t _{d(on)}			19	33	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω		5	10		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		45	81		
Fall Time	t _f			5	10		
Turn-On Delay Time	t _{d(on)}			45	81		
Rise Time	t _r	V_{DD} = 10 V, R_L = 1 Ω		18	43		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		60	110		
Fall Time	t _f			30	60		
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			60	А	
Pulse Diode Forward Current ^a	I _{SM}		-		180		
Body Diode Voltage	V_{SD}	I _S = 4 A		0.71	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			33	50	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, dl/dt = 100 A/µs, T _J = 25 °C		25	40	nC	
Reverse Recovery Fall Time	t _a			16			
Reverse Recovery Rise Time	t _b			17		ns	

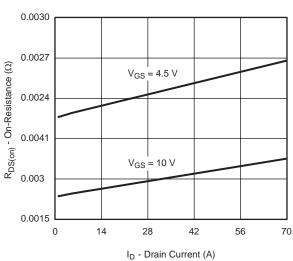
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$ b. Guaranteed by design, not subject to production testing.

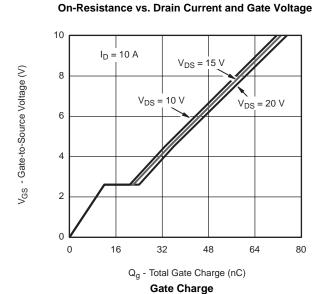
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

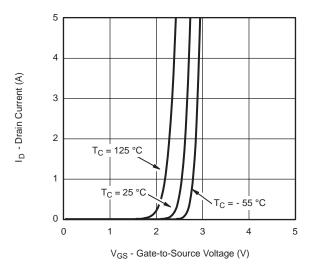


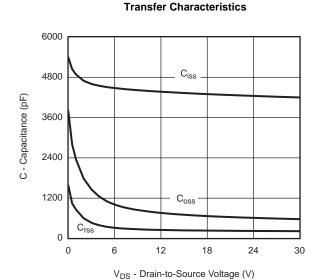
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

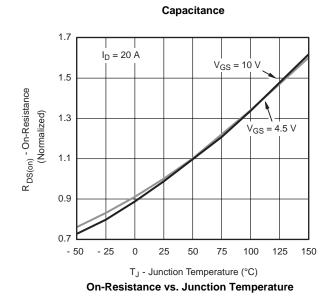




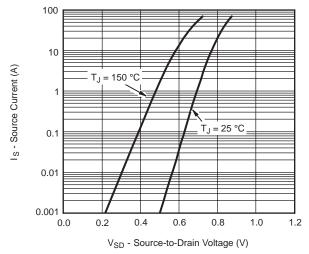




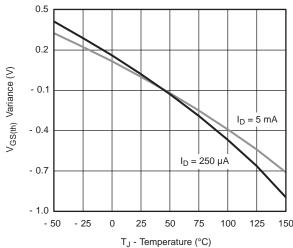




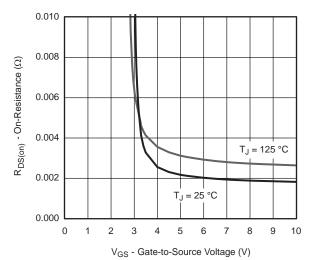
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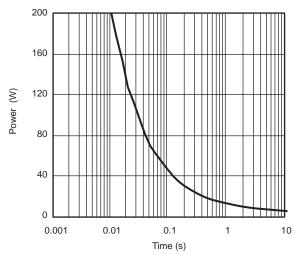
Source-Drain Diode Forward Voltage



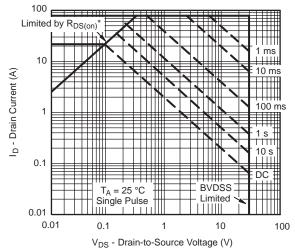
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage



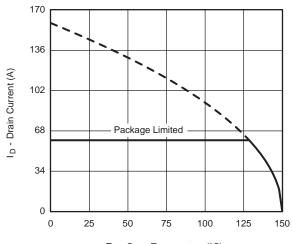
Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

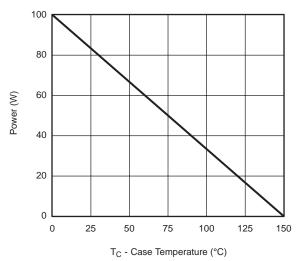
Safe Operating Area, Junction-to-Ambient

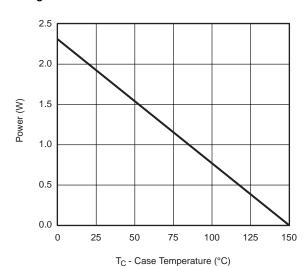
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





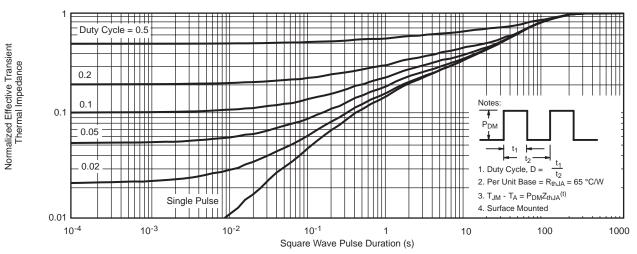
Power, Junction-to-Case

Power, Junction-to-Ambient

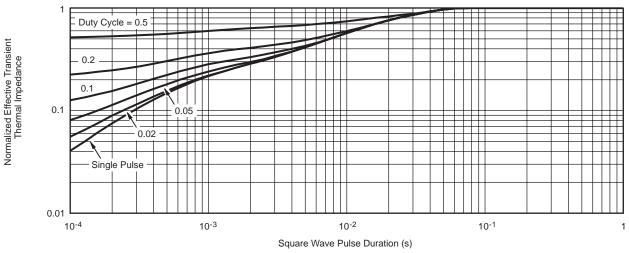
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case





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